Issue Date 2015/3/13

Doc. No. IRC-RT9H321C-E-B

1. Reliability Test Results

Group	Test Items	Test Conditions	Test Quantity	Failure Quantity	Remarks
1	Solderability	Solder Temperature 230°C Immersion Time 5sec Using rosin-type flux	45	0	
2	Resistance to solder heat	Solder Temperature 260°C Immersion Time 10sec Immersing whole device	22	0	
3	Temperature Cycle	Ta=Tstg(min)~Tstg(max) 30min each cycle 100 cycles	45	0	
4	Humidity Resistance	Ta=85°C, 85%R.H. 1000hr	45	0	
5	Temperature Humidity Bias	Ta=85°C, 85%R.H. VKA=2.5V, IK=40mA 1000hr	45	0	
6	High Temperature Bias	Ta=85°C VKA=2.5V, IK=40mA 1000hr	45	0	
7	High Temperature Storage	Ta=Tstg(max) 1000hr	45	0	
8	Low Temperature Storage	Ta=Tstg(min) 1000hr	45	0	
9	Pressure Cooker Test	121°C, 100%RH, 2 × 10 ⁵ Pa 96hr	45	0	
10	Electrostatic Breakdown Resistance	C=200pF, 0Ω Reference: GND pin Applied Voltage ±150V Applied once on each pin	11	0	
10		C=100pF, 1.5k Ω Reference: GND pin Applied Voltage $\pm 1000 V$ Applied once on each pin	11	0	

2. Failure Criteria

Group	Failure Criteria	
1	Less than 95% of the immersed part is covered with solder.	
	Which does not meet the electrical characteristics. Whose change rate exceeds $\pm 20\%$. An apparent change in appearance is observed.	

Measurement conditions are based on the corresponding specification sheet.

For further information of the contents above, please contact our Business Department.